| | Hits | Search Text | DBs |
|---|---|---|---|
| 118 | 2 | microdisplay same substrate same (CMOS near3 (driver IC chip (integrated adj3 circuit))) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB |
| 119 | 6 | microdisplay same substrate and (CMOS near3 (driver IC chip (integrated adj3 circuit))) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB |
| 120 | 0 | microdispla$$ and (mitigat$6 adj3 defects) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 121 | 257 | CMOS and LCD and (mitigat$6) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 122 | 0 | CMOS with LCD same (mitigat$6) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 123 | 0 | CMOS same LCD same (mitigat$6) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 124 | 181 | CMOS same (mitigat$6) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 125 | 36 | microdispla$$ and (mitigat$6) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 126 | 156 | (mitigat$6 adj3 defects) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 127 | 0 | (mitigat$6 adj3 defects) same LCD | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 128 | 4 | (mitigat$6 adj3 defects) and LCD | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 129 | 0 | (mitigat$6 adj3 defects) and (bypass near3 latch) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 130 | 9 | (mitigat$6 adj3 defects) and (bypass) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| 131 | 1176 | (345/93,99,100).CCLS. | USPAT |
| 132 | 111 | S131 and (repaire$2 test spare diagnos$5) | USPAT |

| | Hits | Search Text | DBs |
|---|---|---|---|
| **133** | 36 | S131 and (repaire$2 test spare diagnos$5) and (latch bypass$4) | USPAT |
| **134** | 5 | S131 and (repaire$2 test spare diagnos$5) and ( bypass$4) | USPAT |
| **135** | 0 | S131 and (repaire$2 test spare diagnos$5) and (latch same bypass$4) | USPAT |
| **136** | 32 | S131 and (repaire$2 test spare diagnos$5) and (latch) | USPAT |
| **137** | 1156 | (repaire$2 test spare diagnos$5) and (latch same bypass$4) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| **138** | 355 | (repaire$2 test spare diagnos$5) same (latch same bypass$4) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| **139** | 21 | (repaire$2) same (latch same bypass$4) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| **140** | 175 | (driver) same (latch same bypass$4) | US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB |
| **141** | 113 | (driver) same (latch same bypass$4) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB |
| **142** | 28 | (driver) with (latch with bypass$4) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB |
| **143** | 43 | (driver) same (latch with bypass$4) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB |
| **144** | 15 | S144 not S143 | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB |
| **145** | 0 | (defective near4 driver) same (latch same bypass$4) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB |
| **146** | 0 | ((defective fault$4 bad) with driver) same (latch same bypass$4) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB |
| **147** | 10 | ((defective fault$4 bad) with driver) and (latch same bypass$4) | US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB |
| **148** | 140 | (345/93).CCLS. | USPAT |

| | Hits | Search Text | DBs |
|---|---|---|---|
| **149** | 292 | (345/90).CCLS. | USPAT |
| **150** | 881 | (345/98).CCLS. | USPAT |
| **151** | 388 | (345/99).CCLS. | USPAT |
| **152** | 835 | (345/100).CCLS. | USPAT |
| **153** | 198 | (345/206).CCLS. | USPAT |
| **154** | 1352 | (365/222).CCLS. | USPAT |
| **155** | 172 | (324/770).CCLS. | USPAT |
| **156** | 363 | (313/505).CCLS. | USPAT |